

Application No.	Applicant(s)			
10/600,860	OKA, HIROYUKI			
Examiner	Art Unit			
Hae M Hyeon	2839			

SEARCHED				
Class	Subclass	Date	Examiner	
439	588-589	9/04	hmh	
439	275-276			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Update Search Done	9/04	hmh		
Searched US Reference Cited in US Patent No. 6,116,938				